

Search Notes

Application/Control No.

10/528,754

Examiner

Tai Duong

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

2871

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 349 | 74, 75 | 6/23/2007 | TD |
| | 76, 77 | | |
| | 81, 96 | | |
| 345 | 38 | | |
| | 87 | | |
| 359 | 487, 488 | | |
| | 494, 500 | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST (US PG PUB; US PAT; FPRS; EPO; JPO; DERWENT; IBM_TDB) see search history printout | 6/23/2007 | TD |
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